## Notice of References Cited Application/Control No. 10/722,038 Applicant(s)/Patent Under Reexamination PECK, JEFF Examiner Paras Shah Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,920,834	07-1999	Sih et al.	704/233
*	В	US-6,504,838	01-2003	Kwan, Kenny C.	370/352
*	С	US-6,522,746	02-2003	Marchok et al.	379/406.03
*	D	US-6,658,027	12-2003	Kramer et al.	370/516
*	Ε	US-6,744,757	06-2004	Anandakumar et al.	370/352
*	F	US-6,865,162	03-2005	Clemm, Alexander	370/286
*	G	US-6,990,194	01-2006	Mikesell et al.	379/406.04
*	Н	US-7,027,989	04-2006	Tapadar et al.	704/270
*	1	US-7,180,892	02-2007	Tackin, Onur	370/389
*	J	US-2003/0212550	11-2003	Ubale, Anil W.	704/215
*	К	US-2005/0060149	03-2005	Guduru, Vijayakrishna Prasad	704/233
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	•				
	Q					
	R				•	
	S			•		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.